

Source	$\sigma(x_+^{D^*K})$	$\sigma(x_-^{D^*K})$	$\sigma(y_+^{D^*K})$	$\sigma(y_-^{D^*K})$	$\sigma(x_\xi^{D^*\pi})$	$\sigma(y_\xi^{D^*\pi})$
Neglecting correlations	0.05	0.03	0.19	0.04	0.70	1.48
Efficiency correction of (c_i, s_i)	0.53	0.18	0.18	0.20	0.64	1.73
Invariant mass shape parameter	0.09	0.16	0.20	0.05	0.39	0.06
Fixed yield ratios	0.09	0.03	0.03	0.01	0.33	0.15
Bin dependence of the invariant-mass shape	0.40	0.38	0.41	0.33	1.78	1.57
DP bin migration	0.32	0.70	0.03	0.17	1.2	2.0
Λ_b^0 background	0.97	1.34	0.55	0.77	1.13	1.43
Semileptonic B backgrounds	0.27	1.29	0.02	0.67	0.03	0.04
Merging data subsamples	0.06	0.02	0.12	0.03	0.06	0.34
CP -violation in $B^{\pm,0} \rightarrow DK^{\pm}\pi^{0,\mp}$	0.03	0.13	1.97	0.99	0.13	0.68
Total systematic	1.26	2.04	2.12	1.48	2.66	3.78
Strong-phase inputs (external)	0.41	0.23	0.30	0.64	0.93	0.83
Statistical	3.16	3.55	4.41	3.98	5.00	5.04